

# W-GM-5200

## Wafer Edge Grinding Machine

- Best Seller Machine W-GM-Series
- Improve the Space Efficiency by the Compact Design
- Highly Accurate Grinding by the Synchronized X · Y ·  $\theta$  Support Control
- Easy Operation by Touch Panel
- Measuring of Grinding Result and Automatic Correction



TOKYO SEIMITSU CO., LTD.

## W-GM-5200 Specification

### Basic Specification

Wafer size	Φ300 mm
Wafer thickness	0.6 - 1.0 mm
Wafer shape	Φ300 mm (with notch)
<b>Peipheral Grinding</b>	
Outer diameter (groove)	Φ200 mm
Outer diameter (periphery)	Φ202 mm
Inner diameter	φ 30 mm
Flange thickness	20 mm
Spindle frequency	5000 rpm
Spindle bearing system	Grease lubrication, mechanical bearing system
Spindle driving system	Built-in system
Grinding speed	Any setting possible
<b>Notch grinding</b>	
Outer diameter (groove)	Φ1.8-2.4 mm
Outer diameter (periphery)	Φ3.8 mm
Shank diameter	Φ3 mm
Spindle frequency	80000 rpm
Spindle bearing system	Air bearing system
Spindle driving system	Air turbine system
Signal tower	3-color indicator (the color and flashing / lighting can be changed by key input)

### Option

<b>Low Damage Grinding System</b>	
Spindle frequency	36000 rpm
Spindle bearing system	Air bearing system
Spindle driving system	High Frequency Built-in System
Notch Fine spindle frequency	150000 rpm
Spindle bearing system	Air bearing system
Spindle driving system	High Frequency Built-in System
<b>Wheel profile (Periphery fine)</b>	
Groove Diameter	Φ46.6-42 mm
Outer Diameter	Φ50 mm
Flange Thickness	15 mm
<b>Wheel profile (Notch fine)</b>	
Groove Diameter	Φ1.8 - 2.2 mm
Outer Diameter	Φ3.8
Shank Diameter	Φ3 mm

### Mechanical specifications

<b>Wafer thickness measurement</b>	
Resolution	1 μm
Repeated measurement accuracy	Within ±2 μm
Measuring system	Non-contact system
<b>Alignment mechanism</b>	
System	Laser measuring system
Resolution	1μm
Centering accuracy	Within ±50 μm
<b>Grinding table linear axis (X / Y / Z)</b>	
Resolution	1μm
Driving system	AC servomotor and ball screw
<b>Grinding table revolution axis (θ)</b>	
Resolution	0.001°
Driving system	DD motor and higt resolution mechanism
<b>Grinding table flatness</b>	
Surface fluctuation	Less than 10 μm / 360°
<b>Transfer unit</b>	
Conveying system	Suction conveying system
Vacuum generating source	Vacuum ejector
Wafer identifying sensor	Vacuum sensor
<b>Cleaning unit</b>	
Cleaning system	Spinner cleaning
Drying system	Dry air system
Driving system	AC servomotor
Revolution speed	500-1500 min <sup>-1</sup>
<b>Loading and unloading unit</b>	
Type	Cassette carrier type (with options)
<b>Other specifications</b>	
<b>Dimensions,Weight</b>	
W-GM-5200-3C	2515 (W) x 1475 (D) x 2000 (H) / *2300mm 5000kg *including the signal tower
W-GM-5200-8C	3040 (W) x 1775 (D) x 2000 (H) / *2300mm 5000kg *including the signal tower

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information



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